

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CHAE ET AL.	
		Examiner WILLIAM L. BODDIE	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,459,465	10-2002	Lee, Yun-Bok	349/141
*	B US-6,356,328	03-2002	Shin et al.	349/141
C	US-			
D	US-			
E	US-			
F	US-			
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H	US-			
I	US-			
J	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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